Search Notes



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Applicant(s)/Patent Under Reexamination

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KOHNO ET AL.

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THOMAS DIAZ

SEARCHED

Class	Subclass	Date	Examiner
74	606R, 607	01/08/2009	/TD/
475	246, 230	01/08/2009	/TD/
Updated	above.	07/29/2009	/TD/

SEARCH NOTES

Search Notes	Date	Examiner
Inventor Search done in PALM/eDAN.	01/08/2009	/TD/
Search of US and Foreign patents done in EAST.	01/08/2009	/TD/
Consulted wtih Vinh Luong, primary in 74.	01/08/2009	/TD/
Updated Text search done in EAST.	07/29/2009	/TD/

INTERFERENCE SEARCH

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